Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/824,215	LENG, LU HAO
Examiner	Art Unit
José V. Chen	3637

SEARCHED				
Class	Subclass	Date	Examiner	
108/	27			
	161			
	59			
	153.1			
	157.14			
updated		1/10/2008	JVC	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
108	27			
	59			
	153.1,161	1/10/2008	JVC	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
updated search		
int text search history	1/10/2008	jvc